## Notice of References Cited Application/Control No. 10/765,782 Examiner Luan V. Van Applicant(s)/Patent Under Reexamination SILINGER ET AL. Page 1 of 1

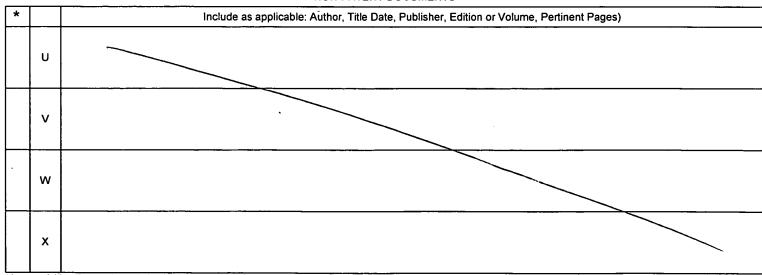
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	C	US-			
	D	US-			
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	-	US-			
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	М	US-			

## **FOREIGN PATENT DOCUMENTS**

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## **NON-PATENT DOCUMENTS**



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